## Application/Control No. Applicant(s)/Patent Under Reexamination 10/611,443 CHOE, SWEE YEW Notice of References Cited Examiner Art Unit Page 1 of 1 Tuan T. Lam 2816 **U.S. PATENT DOCUMENTS** Document Number Country Code-Number-Kind Code Date Name Classification MM-YYYY X US-6,229,745 05-2001 Nambu et al. 365/207 X В US-2001/0008497 07-2001 Horiguchi et al. 365/226 Χ С US-2002/0000624 01-2002 Takemura et al. 257/390 X D US-6,373,763 04-2002 Taito et al. 365/203 US-2004/0170050 09-2004 E Itoh et al. 365/149 F US-US-G US-Н US-US-J US-Κ US-L US-М **FOREIGN PATENT DOCUMENTS Document Number** Date Country Name Classification Country Code-Number-Kind Code MM-YYYY Ν 0 Р Q R S Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) W

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